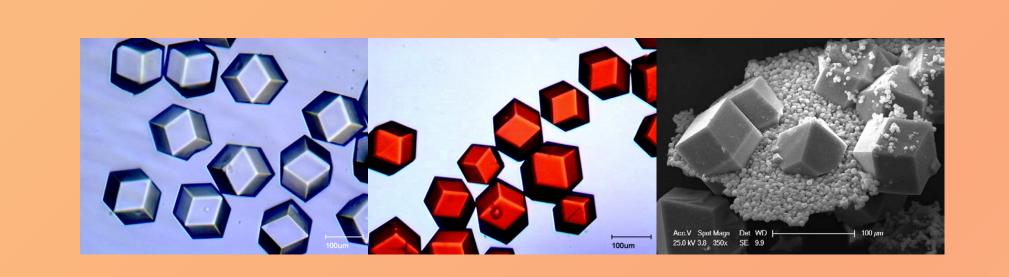
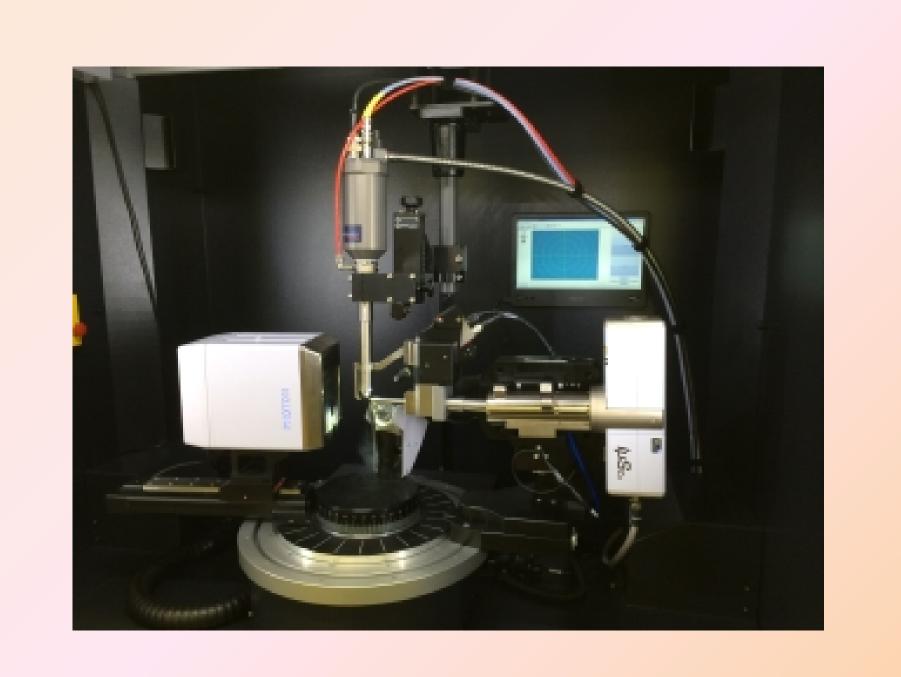


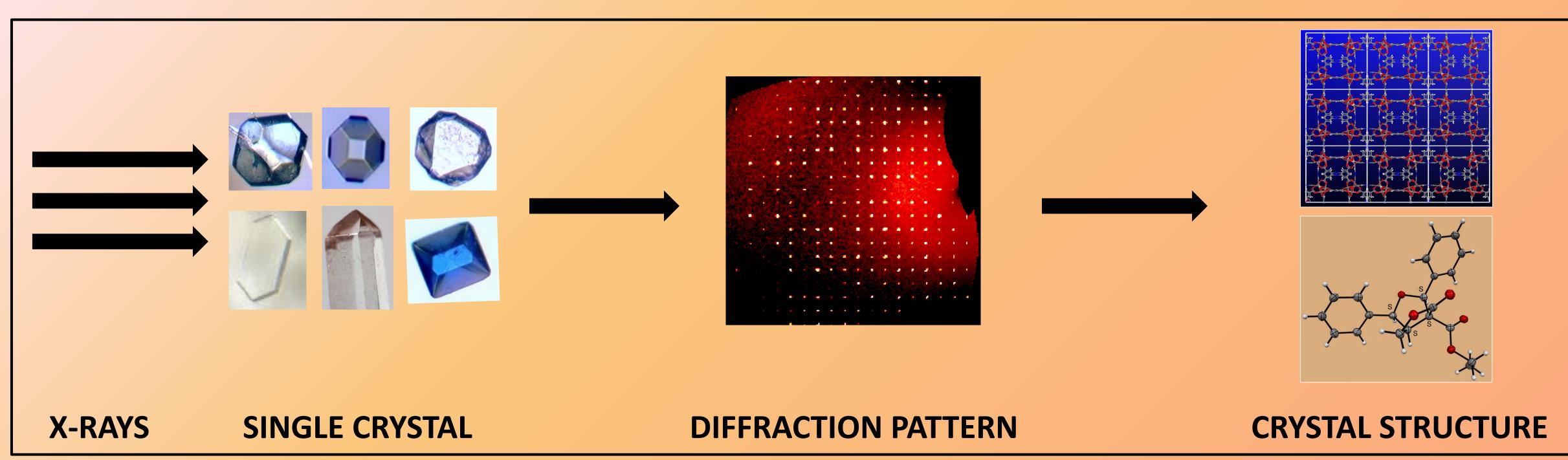
## X-Ray Diffraction Facility at USF

University of South Florida, Department of Chemistry
USF Research Park, 3720 Spectrum Blvd, IDRB 211B, Tampa, Fl 33612
Director: Lukasz Wojtas, PhD; E-mail: lwojtas@usf.edu; Phone: 813-974-3451

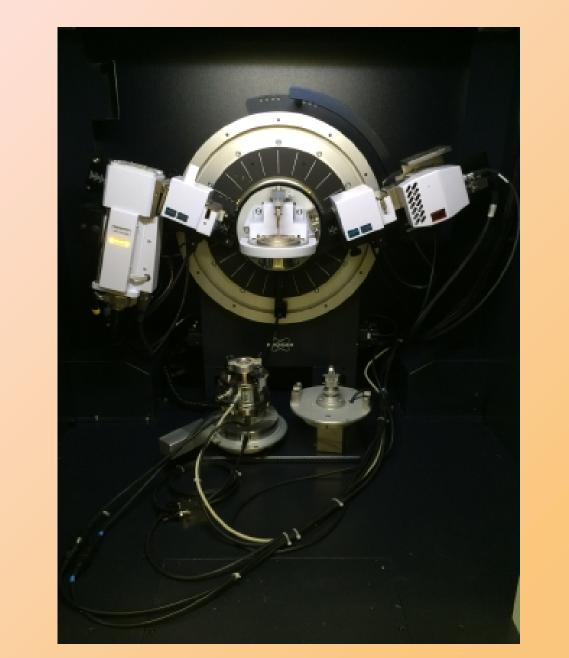




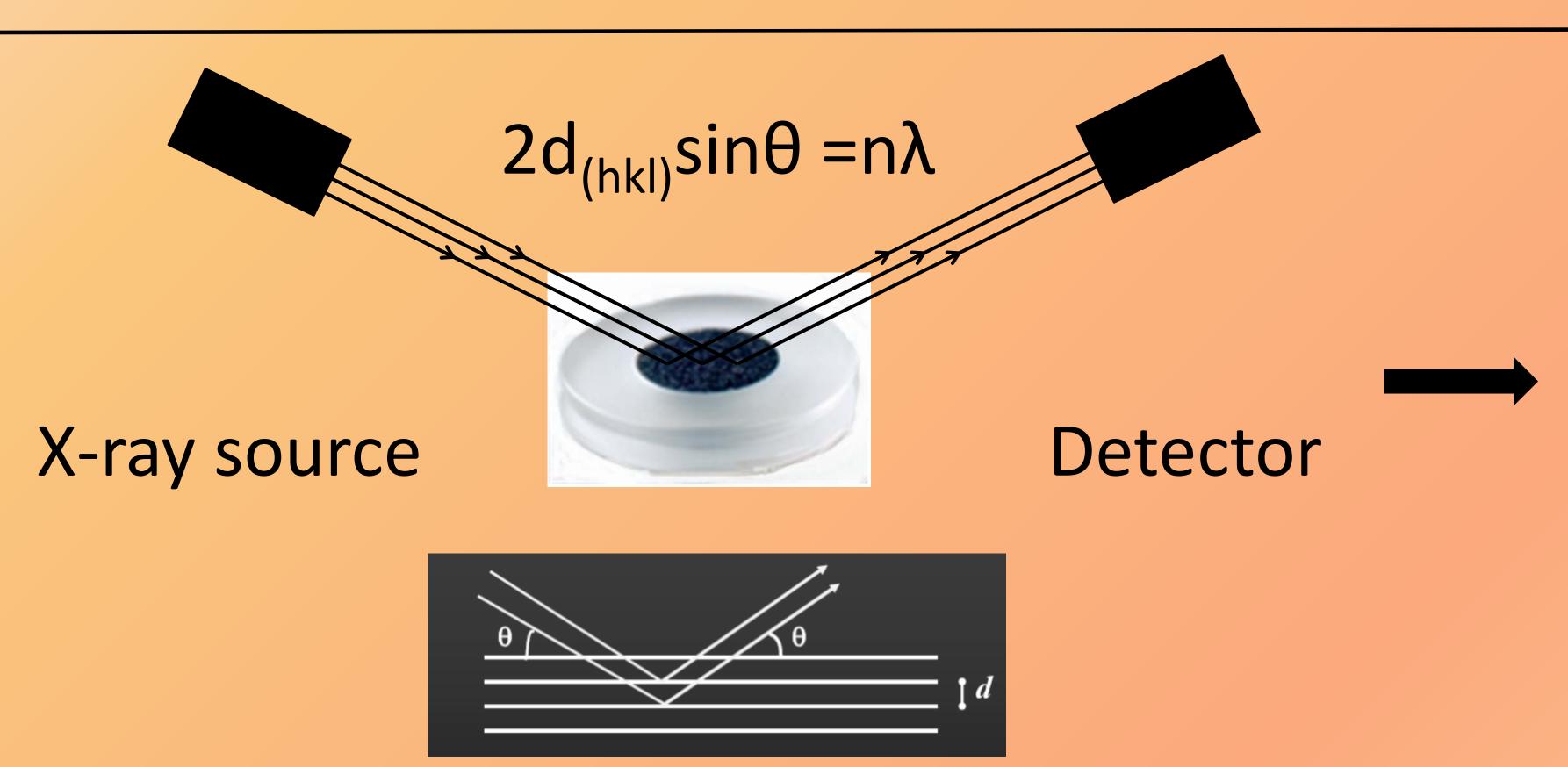
Bruker D8 Venture
Single Crystal X-ray Diffractometer

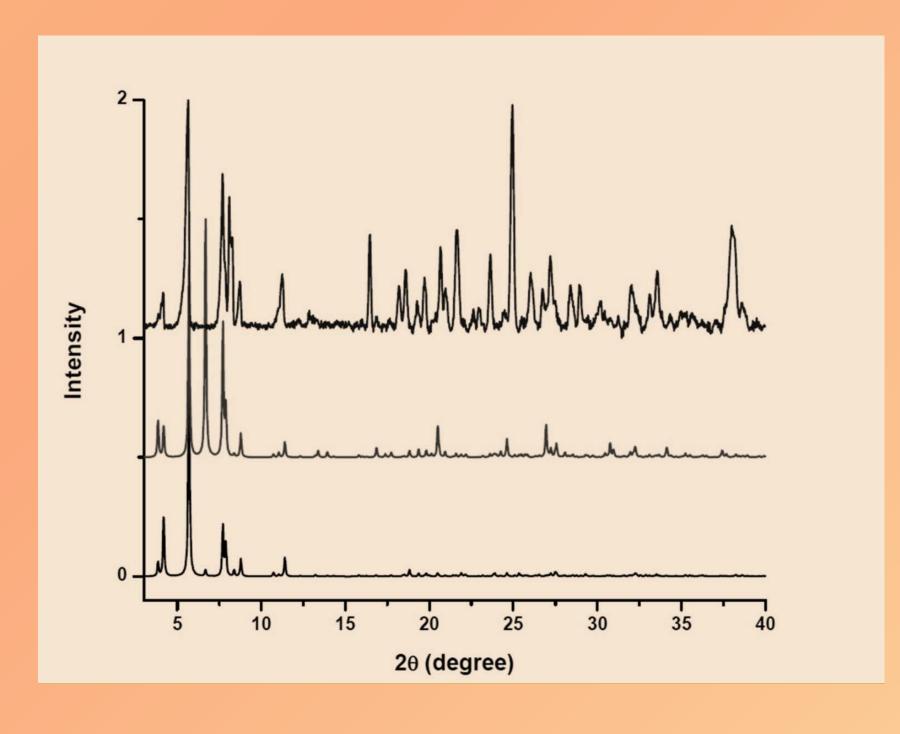


Unit cell determination
Crystal structure determination
Crystal structure analysis
Absolute configuration
Report for Publication



Bruker D8 Advance with DaVinci Powder X-ray Diffractometer





Phase identification
ICDD-PDF2 Database
Quantitative analysis
Indexing
Structure solution

## Bruker D8 Advance Powder Diffractometer with DAVINCI design



- LYNXEYE high-speed detector
- Vertical goniometer in theta-theta configuration so sample stage always remains flat
- Twin-Twin primary and secondary optics for automatic changing from Bragg-Brentano to Parallel Beam geometry and back
- Rotational sample stage
   Capillary stage
- •TTK 450 non-ambient stage
- DIFFRAC.EVA measurement software
- •DIFFRAC.TOPAS software for advanced data manipulation including Rietveld refinement and quantitative analysis

## Bruker D8 VENTURE Single Crystal Diffractometer

## PHOTON 2 CPAD DETECTOR

Air cooled, 100-cm<sup>2</sup> active area Cu-lµS Microfocus X-ray Source

Air cooled !!! Up to 300x more intensity!!!

Low Temperature Device (80-500K)

Application:

Microcrystallography

